

Characterizing dynamic structure in battery electrodes by time-resolved cryo-TEM

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Background

Cryo-TEM aids characterization of sensitive battery materials

Cryogenic transmission electron microscopy (cryo-TEM) is a **valuable tool for characterizing sensitive materials**, as the low temperatures minimize many electron beam-induced artifacts & damage. This has opened new doors in structural analyses of battery materials, where electrode structures & interfaces can now be imaged at higher spatial resolutions than previously accessible.

Sample preparation is a key challenge in cryo-TEM, as samples must be:

- (1) **frozen quickly** to preserve native structures,
- (2) **thin enough** for TEM characterization, and
- (3) **protected from air or moisture**, in the case of battery materials.

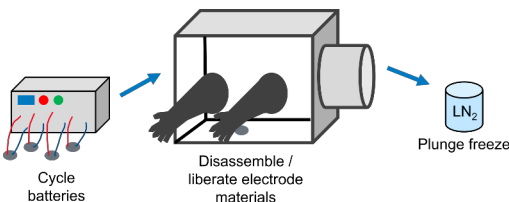


Fig. 1: Schematic of a typical cryo-TEM sample prep workflow. After electrochemical testing, batteries are disassembled in a glovebox, removed, & plunge frozen. Materials of interest can be isolated before freezing or afterwards by cryo-focused ion beam.

Traditional sample prep methods (Fig. 1) leave significant time between electrochemical testing & cryo-TEM characterization. This **limits the time resolution**, allowing for structural relaxation, diffusion, or other dynamic processes & hindering study of transient structures.

$\Delta t \sim 10^3$ s, between electrochemical testing and sample freezing

Goal: Improve time resolution to study dynamic structures

Methods

In-situ freezing to improve temporal resolution of cryo-TEM

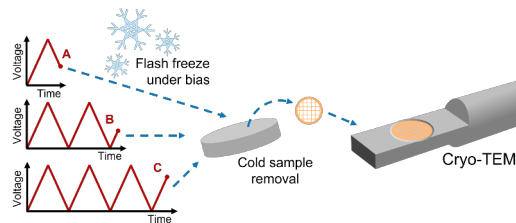


Fig. 2: Flash freezing samples in-situ under applied bias (or current) allows cryo-TEM characterization of transient structures correlating with time points A, B, & C.

1. Integrating plunge freezing with in-situ electrochemical testing

Sample holder developed for Thermo Fisher Vitrobot connects to external potentiostat & allows sample to be plunged into liquid nitrogen (LN_2) at programmed points in electrochemical testing.

$\Delta t_s \approx 1.5$ s, for step-based plunging (e.g. "plunge at 1.5 V")

$\Delta t_t \approx 0.1$ s, for time-based plunging (e.g. "plunge after 10 s")



Fig. 3: Biasing sample holder in Vitrobot.

2. Modified coin cell to remove sample while cold

Electrode prepared on TEM grid. Investigating window materials to break under LN_2 & remove grid for cryo-TEM.

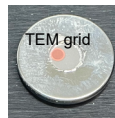


Fig. 4: Coin cell with sapphire window.

Results

Test case: Silicon nanoparticle half cell with GenF electrolyte

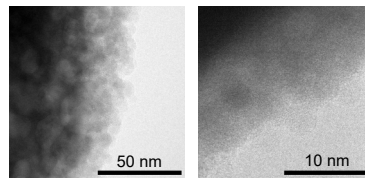


Fig. 5: Silicon nanoparticles deposited onto copper TEM grid.

Modified coin cell with a silicon nanoparticle-coated TEM grid as an anode (Fig. 5), lithium metal counter electrode, Celgard separator, & GenF electrolyte ([1.2 M LiPF_6 in 3:7 w/w EC:EMC] + 3 wt.% FEC).

Plunge freezing & removing TEM grid under LN_2 shows:

- (1) **Electrolyte is vitrified** (Fig. 6a)
- (2) **Nanoparticles visible**; electrolyte layer thickness needs to be optimized for high resolution (Fig. 6b)

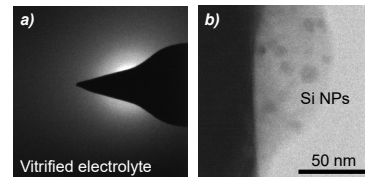


Fig. 6: (a) Cryo-selected area diffraction shows electrolyte is vitrified. (b) Si nanoparticles within the frozen electrolyte layer.

Impacts: Faster time resolution opens doors for future work

We have integrated plunge freezing with electrochemical testing in cryo-TEM sample prep of battery materials, **improving time resolution by 3-4 orders of magnitude**.

In future work:

- Optimize modified coin cell window electrochemically
- Study fast structural & chemical evolution at electrode interfaces
- Extend to other device systems

Acknowledgements: The authors acknowledge Sang-Don Han for insight into modified coin cell designs and Gerard Michael Carroll for preparation of Si nanoparticles. The authors also acknowledge Steve Robbins, Rory Andrykowski, and Jeff Alleman, as well as John Watt and the Center for Integrated Nanotechnologies, for support with Vitrobot modifications.